7435 New Technology Way, Ste A Frederick, MD 21703 301-620-0900 intouch@acdi.com

WANUFACTURING PLANT

100 Industry Ct. Nashville, NC 27856 252-462-4700

WANUFACTURING PLANT

33 Business Park Dr, Unit #4 Branford, CT 06405 203-488-5795

SBA:	Small Business
DUNS:	MD-08-6145646
	NC-04-6673198
	CT-11-820-0324
CAGE	MD-3A2K5
CODE:	NC-6VGN0
	CT-979Y7
NAICS:	334418, 334419, 541330,
	334220, 334310, 334510,
	334511, 336320, 541512,
	336413

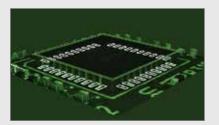
- ITAR Registered
- ANSI/ESD S20.20-2014 Certified
- J-STD-001 Certified
- FDA Registered
- NIST 800-171 Compliant
- Small Business
- SAM Registered

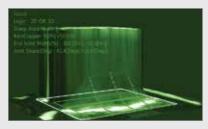
TEST/INSPECTION SERVICES & CAPABILITIES

At ACDi, we understand the importance of meeting the highest standards of quality for your electronics manufacturing project. We offer a full-range of testing services, to ensure our clients' success.

Services	
 Flying probe - Ideal for NPI testing 	 In-circuit test (ICT) - Best suited for production/mature products
Equipment	
 SPEA 4060 Flying Probe In-Circuit PCBA Tester HP SMT 3070 In-Circuit Test System 	 Teradyne TS124 In-Circuit Test System
FUNCTIONAL TESTING	
Basic Services	
 Power-on test 	Customer supplied or developed by ACDi
À la carte Services	
 Operational or complex testing Test fixture development	In-circuit programmingPCB to system level
Equipment	
 Flash programmer – PM3 MPLAB Microchip Programmer 	 Submersible Test Tank (10 ft. depth)
DESIGN & VERIFICATION TESTING (DV)	Γ)
Services	
 Extensive electrical testing & characterization Stress testing 	 In-house temperature testing Support for Mil-Spec environmental testing
Equipment	
 Tenney T10C/T20C Temperature Chambers 	
INSPECTION	
Services	
Automated optical inspection (AOI)SPI	X-RAYFinal QC inspection
Equipment	
 Koh Young KY8030-3 3D Solder Paste Inspection YesTech BX Automated Optical Inspection (AOI) w/ 4 side angle camera CR Technologies CRX 2000 X-Ray 	 Koh Young Zenith 3D Automated Optical Inspection YesTech YTX-3000-130 High Resolution X-R

- Cirris Easy-Touch Pro w/HiPot up to 1500VDC
- Analog and RF Equipment















TEST/INSPECTION PAST PERFORMANCE

Premier Mobile VSAT Antenna Provider

Product : Satellite acquisition and precision antenna positioning module

- Receives, identifies and conditions satellite signal
- Sends satellite signal information to controller board to position antenna

Testing

- Testing process lost in transfer from initial contract manufacturer
- ACDi worked with customer to develop new testing procedures and processes
- Tests include signal strength, filter selection (center frequency and offsets), attenuator selection operation and beacon test
- ACDi testing feedback helped customer to identify timing and tolerance issues in product (which was corrected)

RF Troubleshooting

- Trace RF path through board to find defects
- Set up controls to expected values (filter and attenuator) and check results

Solutions

- Typical RF component failures were Bias-T (broken connection) and low pass filter (degraded operation)
- Typical signaling issues were early manufacturing issues
- Improved the manufacturing process based on failure analysis to minimize future failures – improved first-time failures from > 50% to <1%

Background

Customer changed contract manufacturer of their antenna control system to ACDi, including production, programming, functional test and burn-in test.

Issues Resolved

- ACDi received an incomplete manufacturing package from the customer and reverse engineered as necessary to duplicate the package
- Early production issues included Bias-T and chip-on-chip integrated circuit issues; these led to a variety of issues from power supply shorts to degraded RF signals
 - Refined chip-on-chip SMT process
 - > Troubleshot RF path identifying Bias-T as primary issue
 - > Other typical production issues were identified and resolved
 - First pass yield improved dramatically
- Battery was shorting to chassis added Kapton tape
- Test and setup documentation was incomplete worked with the customer to refine process
- ACDi provided feedback to the customer for test graphical user interface improvements
 - > Changes accepted improved test flow and consistency
 - Found beacon test tolerance issue
 - Greatly improved timing issue causing filter command to inconsistently work (test issue – not product issue)

Recommended changes, including averaging signal digital value for consistency and adding intelligence to burn-in test.